# **SP5055**

## 2.5 GHz BI-DIRECTIONAL I<sup>2</sup>C BUS CONTROLLED SYNTHESISER

The SP5055 is a single chip frequency synthesiser designed for TV tuning systems. Control data is entered in the standard I²C BUS format. The device contains 4 addressable current limited outputs and 4 addressable Bi-Directional open collector ports one of which is a 3 Bit ADC. The information on these ports can be read via the I²C BUS. The device has one fixed I²C BUS address and 3 programmable addresses, programmed by applying a specific input voltage to one of the current limited outputs. This enables 2 or more synthesisers to be used in a system.

The device is available in two variants: the SP5055 in 18-lead plastic DIL (DP18) and the SP5055S in 16-lead miniature plastic DIL (MP16). See Features below for functional differences between the devices.

### **FEATURES**

- Complete 2.5GHz Single Chip System
- Programmable via I2C BUS
- Low power consumption (5V 65mA)
- Low Radiation
- Phase Lock Detector
- Varactor Drive Amp Disable
- 8 Controllable Outputs, 4 Bi-Directional (SP5055)
- 6 Controllable Outputs, 4 Bi-Directional (SP5055S)
- 5 Level ADC
- Variable I<sup>2</sup>C BUS Address For Multi Tuner Applications
- Full ESD Protection \*

### 18 DRIVE OUTPUT CHARGE PUMP CRYSTAL Q1 17 D VEE 16 RE INPUT CRYSTAL Q2 15 AF INPUT SDA [ SP SCL [ 14 0 VCC 5055 † I/O PORT P7 [ 13 PO OUTPUT PORT 12 P1 OUTPUT PORT I/O PORT P6 [ 11 P2 OUTPUT PORT t I/O PORT P5 † I/O PORT P4 10 P3 OUTPUT PORT/ADD **SELECTION PORT DP18** t = Logic level I/O = 3-bit ADC input CHARGE PUMP DRIVE OUTPUT V<sub>EE</sub> CRYSTAL Q1 -CRYSTAL Q2 SP SDA RE INPLIT SCL = 5055S V<sub>CC</sub> PO OUTPUT PORT † 1/O PORT P7 PORT P3/ADD SELECT VO PORT P6 † I/O PORT P5 1/0 PORT P4 + **MP16**

Fig.1 Pin connections - top view

### **APPLICATIONS**

Satellite TV

High IF Cable Tuning Systems

### ORDERING INFORMATION

SP5055 DP - (18 lead Plastic package)
SP5055S MP - (16 lead Miniature Plastic package)

<sup>\*</sup> Normal ESD handling procedures should be observed.

### SP5055

### **ELECTRICAL CHARACTERISTICS**

Test conditions (unless otherwise stated)

T<sub>amb</sub> = -10°C to 80°C, V<sub>CC</sub> = +4.75V TO 5.25V All pin connections refer to DP package.

These characteristics are guaranteed by either production test or design. They apply within the specified ambient temperature and supply voltage unless otherwise stated.

Characteristic	Pin		Value		Units	Conditions	
Characteristic	Pin	Min Typ		Max	Units	Conditions	
Supply current	14		65	80	mA	V <sub>CC</sub> = 5V	
Prescaler Input Voltage	15,16	50		300	mV <sub>RMS</sub>	500MHz to 1.8GHz	
Prescaler Input Voltage	15,16	100		300	mV <sub>RMS</sub>	2.5GHz, see Fig. 5	
Prescaler Input Impedance Input Capacitance	15,16		50 2		Ω pF		
SDA,SCL Input High Voltage Input Low Voltage Input High Current Input Low Current Leakage Current	4,5 4,5 4,5 4,5 4,5	3 0		5.5 1.5 10 -10 10	V V μΑ μΑ	Input Voltage = V <sub>CC</sub> Input Voltage = 0V When V <sub>CC</sub> = 0V	
SDA Output Voltage	4	-		0.4	V	I <sub>sink</sub> = 3mA	
Charge Pump Current Low	1		± 50		μΑ	Byte 4 Bit 2 = 0, Pin 1 = 2V	
Charge Pump Current High	1		± 170		μΑ	Byte 4 Bit 2 = 1, Pin 1 = 2V	
Charge Pump Output Leakage Current	1			±5	n <b>A</b>	Byte 4 Bit 4 = 1, Pin 1 = 2V	
Charge Pump Drive Output Current	18	500			μΑ	V <sub>pin 18</sub> = 0.7V	
Charge Pump Amplifier Gain			6400				
Recommended Crystal Series Resistance		10		200	Ω		
Crystal Oscillator Drive Level			40		mVp-p		
Crystal Oscillator Source Impedance	2		-400		Ω	Nominal Spread ± 15%	
Output Ports							
P0-P3 Sink Current*	13-10	0.7	1	1.5	mA	V <sub>OUT</sub> = 12V	
P0-P3 Leakage Current*	13-10			10	μА	V <sub>OUT</sub> = 13.2V	
P4-P7 Sink Current	9-6	10			mA	V <sub>OUT</sub> = 0.7V	
P4-P7 Leakage Current	9-6			10	μΑ	V <sub>OUT</sub> = 13.2V	
Input Ports							
P3 Input Current High	10			+ 10	μΑ	V <sub>pin10</sub> = 13.2V	
P3 Input Current Low	10			-10	μΑ	V <sub>pin 10</sub> = 0V	
P4,P5,P7 Input Voltage Low	9,8,6			0.8	V		
P4,P5,P7 Input Voltage High	9,8,6	2.7			V		
P6 Input Current High	7			+ 10	μΑ	See Table 3 for ADC Levels	
P6 Input Current Low	7			-10	μΑ		

<sup>\*</sup> Ports P1-P2 not present on the SP5055S.

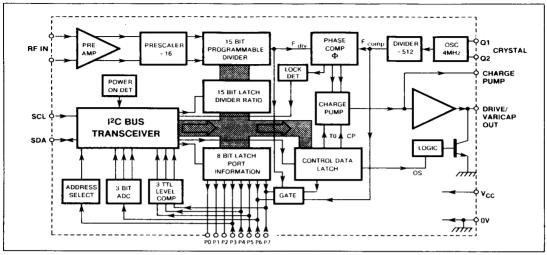


Fig.2 Block diagram of SP5055. (Ports P1-P2 not available on SP5055S)

### **FUNCTIONAL DESCRIPTION**

The SP5055 is programmed from an I2C BUS. Data and Clock are fed in on the SDA and SCL lines respectively as defined by the I2C BUS format. The synthesiser can either accept new data (write mode) or send data (read mode). The Tables in Fig. 3 illustrate the format of the data. The device can be programmed to respond to several addresses, which enables the use of more than one synthesiser in an I2C BUS system. Table 4 shows how the address is selected by applying a voltage to P3. The last bit of the address byte (R/W) sets the device into read mode if it is high and write mode if it is low. When the SP5055 receives a correct address byte it pulls the SDA line low during the acknowledge period and during following acknowledge periods after further data bytes are programmed. When the SP5055 is programmed into the read mode the controlling device accepting the data must pull down the SDA line during the following acknowledge period to read another status byte.

#### WRITE MODE (FREQUENCY SYNTHESIS)

When the device is in the write mode bytes 2+3 select the synthesised frequency while bytes 4+5 select the output port states and charge pump information.

Once the correct address is received and acknowledged, the first bit of the next Byte determines whether that Byte is interpreted as byte 2 or 4, a logic 0 for frequency information and a logic 1 for charge pump and output port information. Additional data bytes can be entered without the need to re-address the device until an I<sup>2</sup>C stop condition is recognised. This allows a smooth frequency sweep for fine tuning or AFC purposes.

If the transmission of data is stopped mid-byte (e.g. by another device on the bus) then the previously programmed byte is maintained.

Frequency data from bytes 2 and 3 is stored in a 15-bit shift register and is used to control the division ratio of the 15-bit programmable divider which is preceded by a divide-by-16 prescaler and amplifier to give excellent sensitivity at the local oscillator input, see Fig. 5. The input impedance is shown in Fig 7.

The programmed frequency can be calculated by multiplying the programmed division ratio by 16 times the comparison frequency F<sub>comp</sub>.

comparison frequency F<sub>comp</sub>.

When frequency data is entered, the phase comparator, via the charge pump and varicap drive amplifier, adjusts the local oscillator control voltage until the output of the programmable divider is frequency and phase locked to the comparison frequency.

The reference frequency may be generated by an external source capacitively coupled into pin 2 or provided by an on-board 4MHz crystal controlled oscillator.

Note - the comparison frequency is 7.8125KHz when a 4MHz reference is used.

Bit 2 of byte 4 of the programming data (CP) controls the current in the charge pump circuit, a logic 1 for  $\pm$  170µA and a logic 0 for  $\pm$  50µA allowing compensation for the variable tuning slope of the tuner and also to enable fast channel changes over the full band. Bit 4 of byte 4 (T0) disables the charge pump if set to a logic 1. Bit 8 of byte 4 (OS) switches the charge pump drive amplifier's output off when it is set to a logic 1. Bit 3 of byte 4 (T1) selects a test mode where the phase comparator inputs are available on P6 and P7, a logic 1 connects  $F_{comp}$  to P6 and  $F_{div}$  to P7

P6 and P7, a logic 1 connects F<sub>comp</sub> to P6 and F<sub>div</sub> to P7 Byte 5 programs the output ports P0 to P7; a logic 0 for a high impedance output and a logic 1 for low impedance (on)

### **READ MODE**

When the device is in the read mode the status data read from the device on the SDA line takes the form shown in Table 2.

Bit 1 (POR) is the power-on reset indicator and is set to a logic 1 if the power supply to the device has dropped below 3V and the programmed information lost (e.g., when the device is initially turned on). The POR is set to 0 when the read sequence is terminated by a stop command. The outputs are all set to high impedance when the device is initially powered up. Bit 2 (FL) indicates whether the device is phase locked, a logic 1 is present if the device is locked and a logic 0 if the device is unlocked.

Bits 3, 4 and 5 (I2,I1,I0) show the status of the I/O Ports P7, P5 and P4 respectively. A logic 0 indicates a low level and a logic 1 a high level. If the ports are to be used as inputs they should be programmed to a high impedance state (logic 1). These inputs will then respond to data complying with TTL type voltage levels. Bits 6, 7 and 8 (A2,A1,A0) combine to give the output of the 5 level ADC.

The 5 level ADC can be used to feed AFC information to the microprocessor from the IF section of the receiver, as illustrated in the typical application circuit.

### **APPLICATION**

A typical Application is shown in Fig. 4. All input/ output interface circuits are shown in Fig. 6.

	MSB							LSB		
ADDRESS	1	1	0	0	0	MA1	МАО	0	Д	BYTE 1
PROGRAMMABLE DIVIDER	0	214	213	212	211	210	29	28	А	BYTE 2
PROGRAMMABLE DIVIDER	27	26	25	24	23	22	21	20	Α	BYTE 3
CHARGE PUMP AND TEST BITS	1	СР	T1	то	1	1	1	os	А	BYTE 4
IO PORT CONTROL BITS	P7	Р6	P5	P4	Р3	P2*	P1*	P0	А	BYTE 5

Table 1 Write data format (MSB is transmitted first)

ADDRESS	1	1	0	0	0	MA1	MA0	1	А	BYTE 1
STATUS BYTE	POR	FL	12	11	10	A2	Α1	Α0	Α	BYTE 2

Table 2 Read data format

A : Acknowledge Bit

MA1, MA0 : Variable address bits (see Table 4)

CP: Charge Pump current select

T1 : Test mode selection

T0: Charge pump disable

OS: Varactor drive Output disable Switch

P7, P6, P5, P4, P3, P2\*, P1\*, P0 : control output states

POR: Power On Reset indicator FL: Phase Lock detect Flag

12, 11, 10: Digital information from Ports P7, P5 and P4, respectively

A2, A1, A0: 5 Level ADC data from P6 (see Table 3)

A2	Α1	Α0	Voltage input to P6
1	0	0	0.6V <sub>CC</sub> to 13.2V
0	1	1	0.45V <sub>CC</sub> to 0.6V <sub>CC</sub>
0	1	0	0.3V <sub>CC</sub> to 0.45 V <sub>CC</sub>
0	0	1	0.15V <sub>CC</sub> to 0.3 V <sub>CC</sub>
0	0	0	0 to 0.15 V <sub>CC</sub>

	MA1	MA0	Voltage input to P3
	0	0	0 - 0.2 V <sub>CC</sub>
į	0	1	ALWAYS VALID
	1	0	0.3 - 0.7 V <sub>CC</sub>
	1	1	0.8 V <sub>CC</sub> - 13.2V

Table 4 Address selection

Table 3 ADC levels

NOTE: \* Don't care condition on SP5055S

Fig. 3 Data Formats

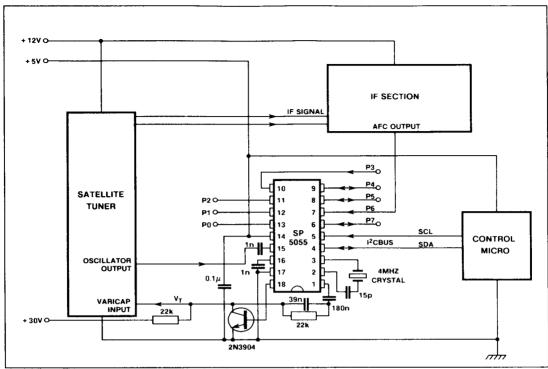


Fig.4 Typical SP5055 application

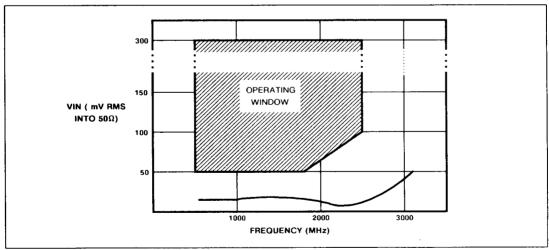


Fig.5 Typical input sensitivity

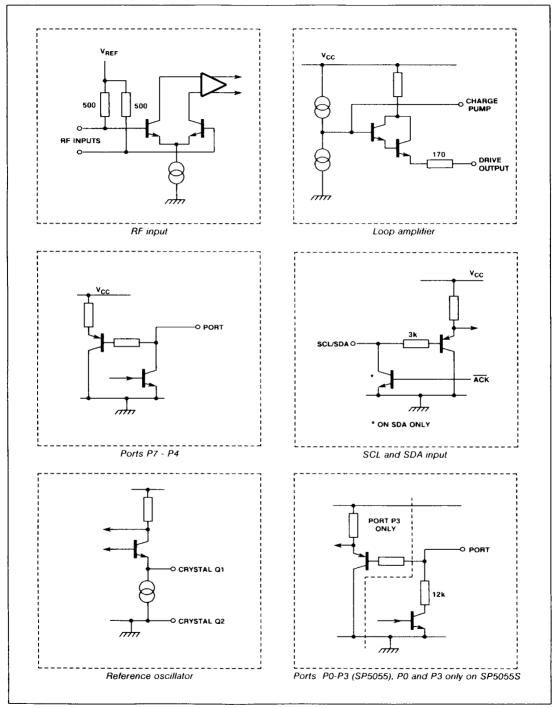


Fig.6 SP5055 inputioutput interface circuits

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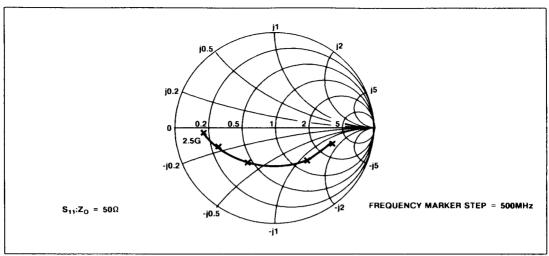


Fig.7 Typical input impedance

### **ABSOLUTE MAXIMUM RATINGS**

All voltages are referred to  $V_{\text{EE}}$  and pin 3 at 0V.

Barrana ta u	Pin	Pin	Vi	alue	Units		
Parameter	SP5055	SP5055S	Min	Min Max		Conditions	
Supply voltage	14	12	-0.3	7	V		
RF input voltage	15, 16	13, 14		2.5	Vp-ρ		
Port voltage	6 - 13 6 - 9 10-13	6 - 11 6 - 9 10, 11	-0.3 -0.3 -0.3	14 6 14	V V	Port in off state Port in on state Port in on state	
Total port output current	6-13	6-11		50	mA		
RF input DC offset	15, 16	13, 14	-0.3	V <sub>CC</sub> + 0.3	V		
Charge pump DC offset	1	1	-0.3	V <sub>CC</sub> + 0.3	٧		
Drive DC offset	18	16	-0.3	V <sub>CC</sub> + 0.3	V		
Crystal oscillator DC offset	2	2	-0.3	V <sub>CC</sub> + 0.3	V		
SDA, SCL input voltage	4, 5	4, 5	-0.3 -0.3	V <sub>CC</sub> + 0.3 5.5	V V	With V <sub>CC</sub> applied V <sub>CC</sub> not applied	
Storage temperature			-55	+ 125	°C		
Junction temperature				+ 150	°C		
DP18 thermal resistance, chip-to-ambient DP18 thermal resistance, chip-to-case				78 24	°C/W °C/W		
MP16 thermal resistance, chip-to-ambient MP16 thermal resistance, chip-to-case				111 41	°C/W		
Power consumption at 5.5V				440	mW	All ports off	